

## NTR4101P, NTRV4101P

### Trench Power MOSFET -20 V, Single P-Channel, SOT-23

#### **Features**

- Leading –20 V Trench for Low R<sub>DS(on)</sub>
- -1.8 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint
- NTRV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Load/Power Management for Portables
- Load/Power Management for Computing
- Charging Circuits and Battery Protection

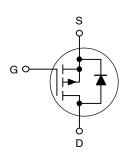
#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value Uni	
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage			V <sub>GS</sub>	±8.0	V
Continuous Drain Current (Note 1)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.4	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		-1.7	
	t ≤ 10 s	T <sub>A</sub> = 25°C		-3.2	
Power Dissipation (Note 1)	Steady T <sub>A</sub> = 25°C State		P <sub>D</sub>	0.73	W
	t ≤ 10 s			1.25	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.8	Α
Current (Note 2)	State	T <sub>A</sub> = 85°C		-1.3	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.42	W
Pulsed Drain Current	tp = 10 μs		I <sub>DM</sub>	-18	Α
ESD Capability (Note 3)		100 pF, 1500 Ω	ESD	225	V
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode)			I <sub>S</sub>	-2.4	Α
Single Pulse Drain-to–Source Avalanche Energy ( $V_{GS}$ = -8 V, $I_L$ = -1.8 Apk, L = 10 mH, $R_G$ = 25 $\Omega$ )			EAS	16	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
	70 mΩ @ -4.5 V	
-20 V	90 mΩ @ -2.5 V	−3.2 A
	112 mΩ @ –1.8 V	

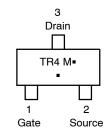
#### P-Channel MOSFET



#### **MARKING DIAGRAM & PIN ASSIGNMENT**



**CASE 318** STYLE 21



TR4 = Device Code = Date Code М = Pb-Free Package (\*Note: Microdot may be in either location)

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTR4101PT1G	SOT-23	3000 / Tape &
NTR4101PT1H	(Pb-Free)	Reel
NTRV4101PT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



# **NTR4101P, NTRV4101P**

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\theta JA}$	100	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	300	

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. ESD Rating Information: HBM Class 0

#### **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		1	I	1	ı	ı
Drain–to–Source Breakdown Voltage (Note 4) (V <sub>GS</sub> = 0 V, I <sub>D</sub> = –250 μA)		V <sub>(BR)DSS</sub>	-20			V
Zero Gate Voltage Drain Current (Note 4) $(V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V})$		I <sub>DSS</sub>			-1.0	μΑ
Gate-to-Source Leakage Current (V <sub>GS</sub> = ±8.0 V, V <sub>DS</sub> = 0 V)		I <sub>GSS</sub>			±100	nA
TY CHARACTERISTICS						
Gate Threshold Voltage (Note 4) $(V_{GS} = V_{DS}, I_D = -250 \mu A)$		V <sub>GS(th)</sub>	-0.4	-0.72	-1.2	V
$\begin{array}{c} \text{Drain-to-Source On-Resistance} \\ \text{(V}_{GS} = -4.5 \text{ V}, \text{I}_{D} = -1.6 \text{ A}) \\ \text{(V}_{GS} = -2.5 \text{ V}, \text{I}_{D} = -1.3 \text{ A}) \\ \text{(V}_{GS} = -1.8 \text{ V}, \text{I}_{D} = -0.9 \text{ A}) \end{array}$		R <sub>DS(on)</sub>		70 90 112	85 120 210	mΩ
Forward Transconductance (V <sub>DS</sub> = -5.0 V, I <sub>D</sub> = -2.3 A)		9 <sub>FS</sub>		7.5		S
CHARGES, CAPACITANCES & GA	TE RESISTANCE					
Input Capacitance		C <sub>iss</sub>		675		pF
Output Capacitance	$(V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = -10 \text{ V})$	C <sub>oss</sub>		100		
Reverse Transfer Capacitance		C <sub>rss</sub>		75		
Total Gate Charge	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q <sub>G(tot)</sub>		7.5	8.5	nC
Gate-to-Source Gate Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q <sub>GS</sub>		1.2		nC
Gate-to-Drain "Miller" Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	$Q_{GD}$		2.2		nC
Gate Resistance		R <sub>G</sub>		6.5		Ω
SWITCHING CHARACTERISTICS	(Note 5)					
Turn-On Delay Time		t <sub>d(on)</sub>		7.5		ns
Rise Time	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A}, R_G = 6.0 \Omega)$	t <sub>r</sub>		12.6		
Turn-Off Delay Time		t <sub>d(off)</sub>		30.2		
Fall Time		t <sub>f</sub>		21.0		
DRAIN-SOURCE DIODE CHARAC	TERISTICS					
Forward Diode Voltage	$(V_{GS} = 0 \text{ V}, I_{S} = -2.4 \text{ A})$	V <sub>SD</sub>		-0.82	-1.2	V
Reverse Recovery Time		t <sub>rr</sub>		12.8	15	ns
Charge Time	$(V_{GS} = 0 \text{ V}, \\ dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, I_{S} = -1.6 \text{ A})$	ta		9.9		ns
Discharge Time	1 7 7 7	t <sub>b</sub>		3.0		ns

<sup>4.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

Reverse Recovery Charge

 $Q_{rr}$ 

1008

nC

<sup>5.</sup> Switching characteristics are independent of operating junction temperature.